WHAT IS CLAIMED IS:

- 1. An apparatus for controlling a fingerprint sensor temperature, comprising:
 - a power source;
 - a temperature sensor for detecting the fingerprint sensor temperature;
- a semiconductor assembly interposed between the fingerprint sensor and the power source for cooling or heating the fingerprint sensor according to a direction of the current from the power source; and
 - a controller controlling the power source based on the fingerprint sensor temperature.
- 10 2. The apparatus of claim 1, wherein the power source comprises a DC source.
 - 3. The apparatus of claim 1, wherein the semiconductor assembly comprises an n-type semiconductor, a p-type semiconductor, an electrode for conjunction between the n-type semiconductor and the p-type semiconductor, two counter electrodes respectively connected to the power source in series, and an intermediate element for heat transfer between the electrode and the fingerprint sensor.
 - 4. The apparatus of claim 3, wherein the intermediate element is formed with silicon.
- 20 5. The apparatus of claim 4, wherein:

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in the case that the detected fingerprint sensor temperature is within a predetermined temperature range, the controller controls the power source to be off;

in the case that the detected fingerprint sensor temperature is higher than the highest temperature of the predetermined temperature range, the controller controls the power source to supply a reverse bias current to the semiconductor assembly; and

in the case that the detected fingerprint sensor temperature is lower than the lowest temperature of the predetermined temperature range, the controller controls the power source to supply a forward bias current to the semiconductor assembly.

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- 6. The apparatus of claim 5, wherein the predetermined temperature range includes 25° C to 37° C.
- 7. The apparatus of claim 1, further comprising a door unlock sensor, wherein the controller connects the power source to the semiconductor assembly only if a door unlock signal is detected by the door unlock sensor.
 - 8. A method for controlling a fingerprint sensor temperature, utilizing a thermoelectric semiconductor assembly connected to a power source, comprising:
 - detecting the fingerprint sensor temperature, determining whether the detected fingerprint sensor temperature is within a predetermined temperature range;

cutting off the power source to the semiconductor assembly if the detected fingerprint sensor temperature is within the predetermined temperature range;

applying a reverse bias current to the semiconductor assembly from the power source if the detected fingerprint sensor temperature is higher than the highest temperature of the predetermined temperature range; and

applying a forward bias current to the semiconductor assembly from the power source if the detected fingerprint sensor temperature is lower than the lowest temperature of the predetermined temperature range.

- 9. The method of claim 8, further comprising detecting a door unlock signal before detecting the fingerprint sensor temperature, wherein the semiconductor assembly is connected to the power source if the door unlock signal is detected.
- 5 10. The method of claim 8, wherein the power source is a DC source.
 - 11. The method of claim 8, wherein the semiconductor assembly is a thermoelectric semiconductor assembly.
- 10 12. An apparatus for controlling temperature of a fingerprint sensor, comprising: a power source;

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- a temperature sensor configured to sense temperature at the fingerprint sensor;
- a semiconductor assembly configured and dimensioned to be disposed between the fingerprint sensor and said power source;
- a controller communicating with said power source and receiving signals from said temperature sensor, said controller being programmed to turn off the power source when the sensed temperature is within a predetermined range, supply a reverse bias current from the power source to the semiconductor assembly when the sensed temperature is higher than the predetermined range; and supply a forward bias current from the power source to the semiconductor assembly when the sensed temperature is lower than the predetermined range.
- 13. The apparatus of claim 12, wherein said semiconductor assembly comprises a thermoelectric semiconductor assembly and the power source is a DC power source.
- 14. The apparatus of claim 12, wherein said semiconductor assembly comprises:

an n-type semiconductor;

a p-type semiconductor;

an electrode extending between said semiconductors;

an intermediate element formed on said electrode and configured for contact with the

5 fingerprint sensor; and

a counter electrode connected between each semiconductor and the power source.

15. The apparatus of claim 14, wherein said intermediate layer is a silicon layer for facilitating heat transfer.